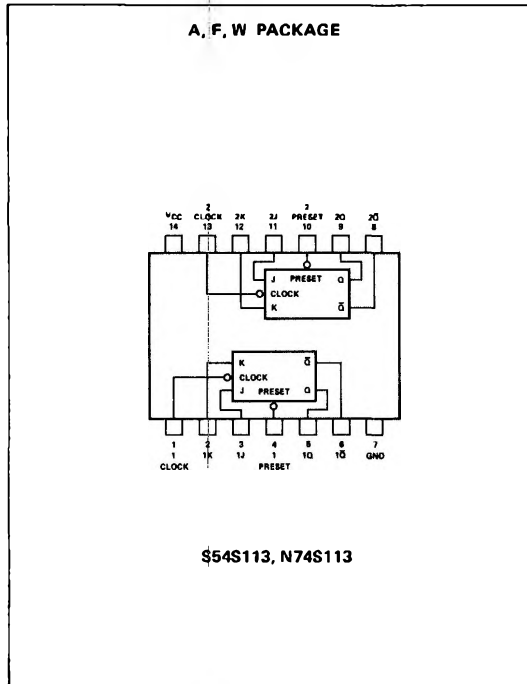


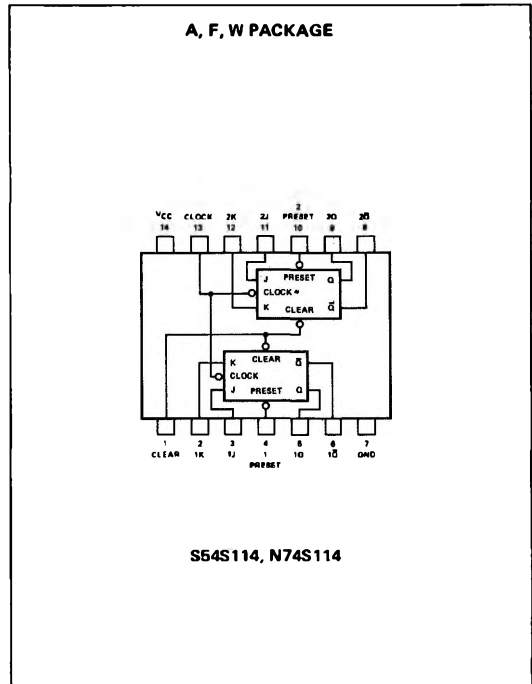
S54S113--A,F,W • S54S114--A,F,W • N74S113--A,F • N74S114--A,F

DIGITAL 54/74 TTL SERIES

PIN CONFIGURATIONS



PIN CONFIGURATIONS



DESCRIPTION

The S54S113 and N74S113 offer individual J, K, preset, and clock inputs. The S54S114 and N74S114 offer common clock and common clear inputs and individual J, K, and preset inputs.

These monolithic dual flip-flops are designed so that when the clock goes high, the inputs are enabled and data will be accepted. The logic level of the J and K inputs may be allowed to change when the clock pulse is high and the bistable will perform according to the truth table as long as minimum setup times are observed. Input data are transferred to the outputs on the negative-going edge of the clock pulse.

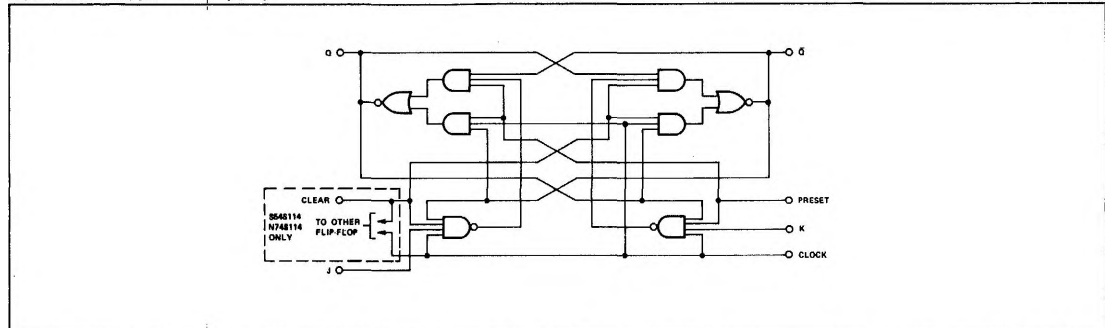
TRUTH TABLE

t_n		t_{n+1}
J	K	Q
L	L	Q_n
L	H	L
H	L	H
H	H	$\overline{Q_n}$

NOTES:

- A. t_n = bit time before clock pulse
- B. t_{n+1} = bit time after clock pulse

LOGIC DIAGRAM (each flip-flop)



DIGITAL 54/74 TTL SERIES ■ S54S113, N74S113, S54S114, N74S114

RECOMMENDED OPERATING CONDITIONS

	S54S113, S54S114			N74S113, N74S114			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply Voltage V_{CC}	4.5	5	5.5	4.75	5	5.25	V
Normalized Fan-Out from each Output, N:	High logic level			20			MHz
	Low logic level			10			
Input Clock Frequency, f_{clock}	0		80	0		80	MHz
Width of Clock Pulse, $t_w(\text{clock})$	6			6			ns
Width of Preset Pulse, $t_w(\text{preset})$	8			8			ns
Width of Clear Pulse, $t_w(\text{clear})$: S54S114, N74S114	8			8			ns
Input Setup Time, t_{setup}	3			3			ns
Input Hold Time, t_{hold}	0			0			ns
Operating-Free-Air Temperature, T_A	-55		125	0		70	°C

ELECTRICAL CHARACTERISTICS (over recommended operating free-air temperature range unless otherwise noted)

PARAMETER		TEST CONDITIONS*	S54S113 N74S113			S54S114 N74S114			UNIT
			MIN	TYP**	MAX	MIN	TYP**	MAX	
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.8			0.8	V
V_I	Input clamp voltage	$V_{CC} = \text{MIN}$, $I_I = -18\text{mA}$			-1.2			-1.2	V
V_{OH}	High-level output voltage	$V_{CC} = \text{MIN}$, $V_{IH} = 2\text{V}$, Series 54S	2.5	3.4		2.5	3.4		V
		$V_{IL} = 0.8\text{V}$, $I_{OH} = -1\text{mA}$, Series 74S	2.7	3.4		2.7	3.4		V
V_{OL}	Low-level output voltage	$V_{CC} = \text{MIN}$, $V_{IH} = 2\text{V}$, $V_{IL} = 0.8\text{V}$, $I_{OL} = 20\text{mA}$			0.5			0.5	V
I_I	Input current at maximum input voltage	$V_{CC} = \text{MAX}$, $V_I = 5.5\text{V}$			1			1	mA
		J or K input			50			50	mA
I_{IH}	High-level input current	$V_{CC} = \text{MAX}$, $V_I = 2.7\text{V}$, Clock			100			200	μA
		Preset			100			100	μA
		Clear			200			200	μA
I_{IL}	Low-level input current	J or K input			-1.6			-1.6	mA
		Clock			-4			-8	mA
		Preset			-7			-7	mA
	Clear						-14	mA	
I_{OS}	Short circuit output current†	$V_{CC} = \text{MAX}$	-40		-100	-40		-100	mA
I_{CC}	Supply current	$V_{CC} = \text{MAX}$, See Note 1		30	50		30	50	mA

SWITCHING CHARACTERISTICS, $V_{CC} = 5\text{V}$, $T_A = 25^\circ\text{C}$, $N = 10$

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
f_{max}	Maximum clock frequency				80	125		MHz
t_{PLH}	Propagation delay time, low-to-high-level output, from clear or preset				2	4	7	ns
t_{PHL}	Propagation delay time, high-to-low-level output, from clear or preset	$C_L = 15\text{pF}$, $R_L = 280\Omega$		NOTE 2	2	5	7	ns
t_{PLH}	Propagation delay time, low-to-high-level output, from clock				2	4	7	ns
t_{PHL}	Propagation delay time, high-to-low-level output, from clock				2	5	7	ns

* For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type. See Figures 64 through 69 of the Series 54H/74H section for test circuits.

** All typical values are at $V_{CC} = 5\text{V}$, $T_A = 25^\circ\text{C}$.

† Not more than one output should be shorted at a time, and duration of the short-circuit test should not exceed one second.

NOTE 1: I_{CC} is measured with outputs open, clock grounded, and J, K, preset, and clear at 4.5V.

2. Load circuit and waveforms are shown on page 2-293